



November 1997

FDC653N

N-Channel Enhancement Mode Field Effect Transistor

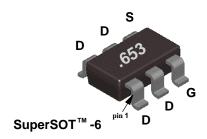
General Description

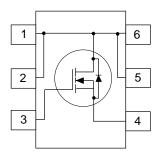
This N-Channel enhancement mode power field effect transistors is produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications in notebook computers, portable phones, PCMICA cards, and other battery powered circuits where fast switching, and low in-line power loss are needed in a very small outline surface mount package.

Features

- $\begin{tabular}{ll} & \bullet & 5~A,~30~V. & R_{DS(ON)} = 0.035~\Omega & @~V_{GS} = 10~V \\ & R_{DS(ON)} = 0.055~\Omega & @~V_{GS} = 4.5~V. \end{tabular}$
- Proprietary SuperSOTTM-6 package design using copper lead frame for superior thermal and electrical capabilities.
- High density cell design for extremely low R_{DS/ON}.
- Exceptional on-resistance and maximum DC current capability.







Absolute Maximum Ratings $T_A = 25$ °C unless otherwise note

Symbol	Parameter		FDC653N	Units
V _{DSS}	rain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage - Continuous		±20	V
I _D	Drain Current - Continuous	(Note 1a)	5	A
	- Pulsed		15	
P _D	Maximum Power Dissipation	(Note 1a)	1.6	W
		(Note 1b)	0.8	
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to 150	℃
THERMA	AL CHARACTERISTICS	·		
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	30	°C/W



Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	30			V
Δ BV _{DSS} / Δ T _J	Breakdown Voltage Temp. Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C		31		mV /°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \ V_{GS} = 0 \text{ V}$			1	μA
		$T_{J} = 55^{\circ}C$			10	μA
I _{GSSF}	Gate - Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V			-100	nA
ON CHARA	ACTERISTICS (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1	1.7	2	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold VoltageTemp.Coefficient	I _D = 250 μA, Referenced to 25 °C		-4.2		mV /°C
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 5 A		0.027	0.035	Ω
		$T_{J} = 125^{\circ}$		0.042	0.056	1
		$V_{GS} = 4.5 \text{ V}, I_D = 4.2 \text{ A}$		0.046	0.055	
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	8			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 5 \text{ A}$		6.2		S
DYNAMIC (CHARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, \ V_{GS} = 0 \text{ V},$		350		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		220		pF
C _{rss}	Reverse Transfer Capacitance			80		pF
SWITCHING	CHARACTERISTICS (Note 2)			•		
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 10 \text{ V}, I_{D} = 1 \text{ A},$		7.5	15	ns
t _r	Turn - On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		12	25	ns
$\mathbf{t}_{D(off)}$	Turn - Off Delay Time			13	25	ns
t,	Turn - Off Fall Time			6	15	ns
Q_g	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_{D} = 5 \text{ A},$		12	17	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V		2.1		nC
Q_{gd}	Gate-Drain Charge			2.6		nC
DRAIN-SOL	IRCE DIODE CHARACTERISTICS			1	1	1
Is	Continuous Source Diode Current				1.3	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A}$ (Note 2)		0.75	1.2	V
		$T_{J} = 125^{\circ}$		0.6	1	

Notes:

^{1.} R_{gak} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{gac} is guaranteed by design while R_{goa} is determined by the user's board design.

a. 78°C/W when mounted on a minimum on a 1 in² pad of 2oz Cu in FR-4 board.

b. 156°C/W when mounted on a minimum pad of 2oz Cu in FR-4 board.

^{2.} Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2.0%.



Typical Electrical Characteristics

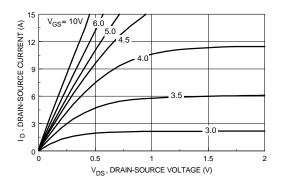


Figure 1. On-Region Characteristics.

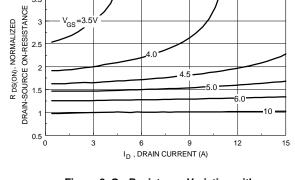


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

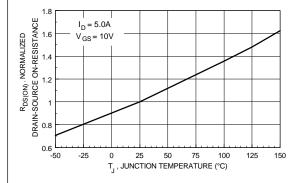


Figure 3. On-Resistance Variation with Temperature.

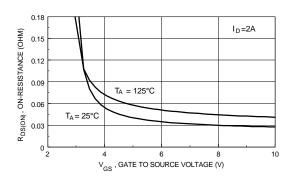


Figure 4. On Resistance Variation with Gate-To- Source Voltage.

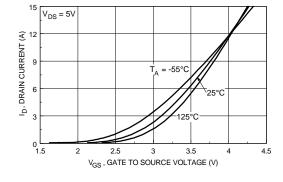


Figure 5. Transfer Characteristics.

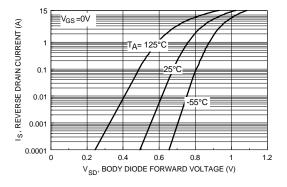


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



Typical Electrical And Thermal Characteristics

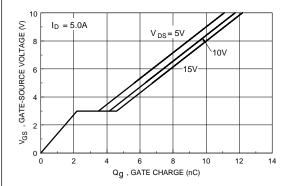


Figure 7. Gate Charge Characteristics.

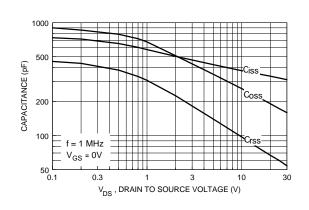


Figure 8. Capacitance Characteristics.

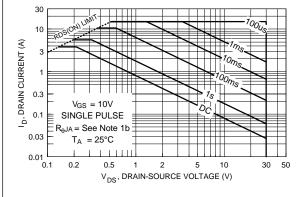


Figure 9. Maximum Safe Operating Area.

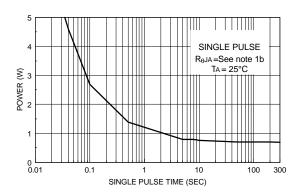


Figure 10. Single Pulse Maximum Power Dissipation.

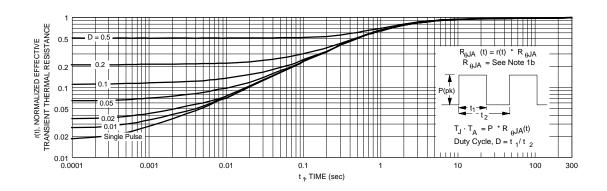


Figure 11. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1b.Transient thermal response will change depending on the circuit board design.



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Datasheet Identification	Product Status	Definition
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General description

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Product status/pricing/packaging

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Product	Product status	Pb-free Status	Pricing*	Package type	Leads	Packing method	Package I

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FDC653N	Full Production	Full Production	\$0.372	SSOT-6	6	TAPE REEL	Line 1: &E& Y (Bi Line 2: .653
FDC653N_NB3E005A	Full Production	Full Production	N/A	SSOT-6	6	TAPE REEL	Line 1: &E& Y (Bi Line 2: .653
FDC653N_NF073	Full Production	Full Production	N/A	SSOT-6	6	TAPE REEL	Line 1: &E& Y (Bi Line 2: .653

^{*} Fairchild 1,000 piece Budgetary Pricing

** A sample button will appear if the part is available through Fairchild's on-line samples program. If there is no sample button, ple contact a Fairchild distributor to obtain samples



Indicates product with Pb-free second-level interconnect. For more information click here.

Package marking information for product FDC653N is available. Click here for more information .

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Models

Package & leads	Condition	Temperature range	Software version
		PSPICE	
SSOT-6-6	<u>Electrical</u>	25°C to 125°C	Orcad 9.1

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Qualification Support

Click on a product for detailed qualification data

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